

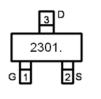
ASSF2301UP

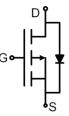
Main Product Characteristics:

V _{DSS}	-20V				
R _{DS} (on)	62mΩ(typ.)				
I _D	-2.6A				



SOT-23





Marking and Pin Assignments

Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- AEC-Q101 qualified



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V(1)	-2.6	А
I _{DM}	Pulsed Drain Current2	-10	A
$P_{D} @ T_{C} = 25^{\circ}C$	Power Dissipation ③	1.25	W
V _{DS}	Drain-Source Voltage	-20	V
V _{GS}	Gate-to-Source Voltage	± 12	V
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
R _{θJC}	Junction-to-case3		100	°C/W

Electrical Characterizes @T_A=25°Cunless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	-20	_	—	V	$V_{GS} = 0V, I_D = -250 \mu A$
R _{DS(on)}	Static Drain-to-Source on-resistance	—	62	75	mΩ	V _{GS} =-4.5V,I _D =-2A
			77	95	mΩ	V _{GS} =-2.5V,I _D =-1.8A
$V_{GS(th)}$	Gate threshold voltage	-0.4	—	-1	V	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$
I _{DSS}	Drain-to-Source leakage current	—	—	-1	μA	V_{DS} =-20V, V_{GS} = 0V
	Cata to Source forward lookage	_	_	100	nA	V _{GS} =12V
I _{GSS}	Gate-to-Source forward leakage	_	—	-100	na I	V _{GS} = -12V
Qg	Total gate charge	_	5.8	—		I _D = -2.3A,
Q_{gs}	Gate-to-Source charge	_	0.8	—	nC	V _{DS} =-6V,
Q_{gd}	Gate-to-Drain("Miller") charge	_	1.6	—		V _{GS} = -4.5V
t _{d(on)}	Turn-on delay time	_	7	—		
t _r	Rise time	_	14	—		V_{GS} =-4.5V, V_{DD} =-20V, R _{GEN} =3Ω
t _{d(off)}	Turn-Off delay time	_	20	—	ns	
t _f	Fall time	_	7	—		R _L =10Ω
C _{iss}	Input capacitance	_	400	—		$V_{GS} = 0V$
Coss	Output capacitance	_	55	—	pF	V _{DS} = -20V
C _{rss}	Reverse transfer capacitance	_	45	—		f = 1MHz

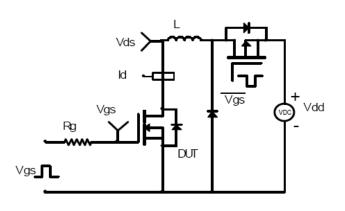
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)	_	_	-2.6	А	MOSFET symbol
I _{SM}	Pulsed Source Current (Body Diode)			-10	А	integral reverse G⊶ + ♥ p-n junction diode.
V _{SD}	Diode Forward Voltage		-0.8	-1.2	V	I _S =-1A, V _{GS} =0V

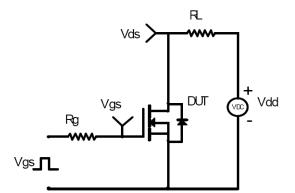


Test Circuits and Waveforms

EAS Test Circuit:

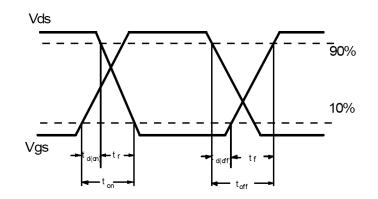


Switching Time Test Circuit:



Switching Waveforms:

Gate Charge Test Circuit:



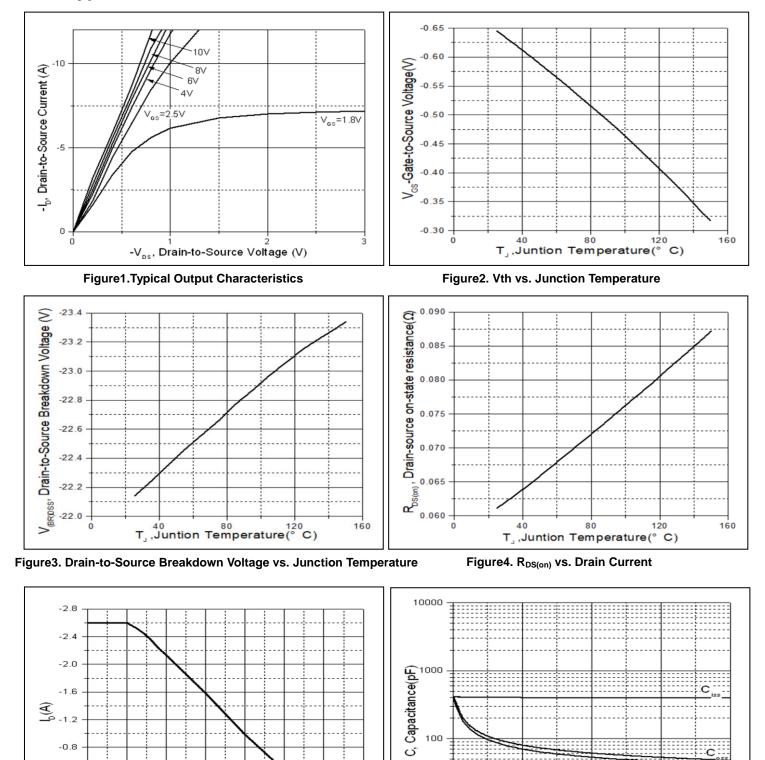
Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- 2 Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.



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Typical Electrical and Thermal Characteristics



75

Figure 5. Drain Current vs. Case Temperature

T_c(°C)

100

125

150

175

-0.4

0.0

25

50

10 | 0

-5

-10

V_{DS}, Drain-to-Source Voltage (V)

Figure6. Capacitance

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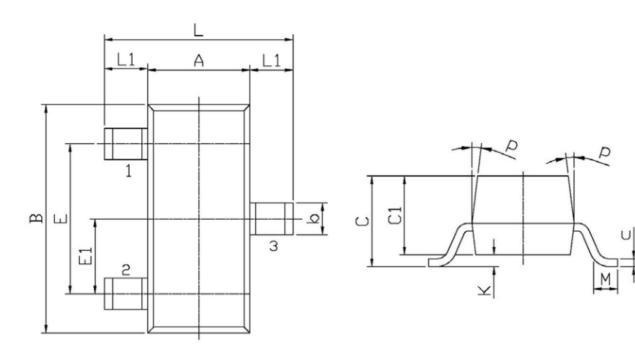
-20



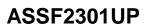
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Mechanical Data:

SOT-23 Package Outline(Unit:mm)



Symbol	Dimensions In Millmeters		Sumbal	Dimensions In Millmeters	
Symbol	Min	Max	Symbol	Min	Max
L	2.2	2.7	С	1.30Ma×	
L1	0.45	0.65	C1	0.90	1.20
A	1.15	1.50	C	0.05	0.20
В	2.70	3.10	К	0 0.10	
E	1.70	2.10	М	0.20MIN	
E1	0.85	1.05	Ρ	7°	
b	0.35	0.55			





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